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FGH50T65UPD 650V, 50A Field Stop Trench IGBT

Features

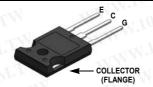
- Maximum Junction Temperature : T_J = 175°C
- · Positive Temperaure Co-efficient for easy parallel operating
- · High current capability
- Low saturation voltage: $V_{CE(sat)} = 1.65V(Typ.) @ I_C = 50A$
- 100% of parts tested I_{LM(2)}
- · High input impedance
- · Tightened Parameter Distribution
- · RoHS compliant
- Short Circuit Ruggedness > 5us @25°C

General Description

Using Novel Field Stop Trench IGBT Technology, Fairchild's new series of Field Stop Trench IGBTs offer the optimum performance for Solar Inverter , UPS, Induction Heating and Digital Power Generator where low conduction and switching losses are essential.

Applications

Solar Inverter, UPS, Induction Heating, Digital Power Generator





Absolute Maximum Ratings

Symbol	Description		Ratings	Units	
V _{CES}	Collector to Emitter Voltage	M. in. COm	650	Y.COV	
V _{GES}	Gate to Emitter Voltage	MAN TOO	± 25	CAM	
I _C	Collector Current	$@T_{C} = 25^{\circ}C$	100	A	
	Collector Current	@ T _C = 100°C	50	A M	
I _{CM (1)}	Pulsed Collector Current		150	100 A	
I _{LM (2)}	Clamped Inductive Load Current @ T _C = 25°C		150	A CU	
l _F	Diode Forward Current	$@T_{C} = 25^{\circ}C$	60	A, CO	
	Diode Forward Current	$@T_C = 100^{\circ}C$	30	N.10A	
I _{FM(1)}	Pulsed Diode Maximum Forward Current		150	Α	
P _D	Maximum Power Dissipation	@ $T_C = 25^{\circ}C$	340	W	
י ט	Maximum Power Dissipation	$@T_C = 100^{\circ}C$	170	W	
SCWT	Short Circuit Withstand Time	@ T _C = 25°C	5	us	
T _J	Operating Junction Temperature	MAL	-55 to +175	°C	
T _{stg}	Storage Temperature Range	MM	-55 to +175	°C	
T _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

Notes

1: Repetitive rating: Pulse width limited by max. junction temperature

2: Ic = 150A, Vce = 400V, Rg = 10Ω

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	100	0.44	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case	4111	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	MAN	40	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Eco Status	Packing Type	Qty per Tube
FGH50T65UPD	FGH50T65UPD	TO-247	WW OV.C	J. T. T.	30ea

For Fairchild's definition of "green" Eco Status, please visit: http://www.fairchildsemi.com/company/green/rohs green.html.

Electrical Characteristics of the IGBT T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics (CO)					
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V$, $I_C = 1mA$	650	ON- T	W -	V
ΔBV _{CES}	Temperature Coefficient of Breakdown Voltage	V _{GE} = 0V, I _C = 1mA	1100X.	0.6	TW-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$	100	Co	250	μΑ
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$	111.	V.COD	±400	nA
On Charac	eteristics	Y.COM.TW W	MM:Ing	OY.CO	WIIW	
V _{GE(th)}	G-E Threshold Voltage	I_C = 50mA, V_{CE} = V_{GE}	4.0	6.0	7.5	V
100	OW.1	I _C = 50A, V _{GE} = 15V	-W-W-1	1.65	2.3	V
V _{CE(sat)} Collector to Emitter Saturation Voltage		I _C = 50A, V _{GE} = 15V, T _C = 175°C	WAM	2.1	COM.	V
Dynamic 0	Characteristics	1 100Y.COM.TW	WWW	W.1007	I.CON	I.TW
C _{ies}	Input Capacitance	1100Y.CO.T.TW	1/1/1	3540	4710	pF
C _{oes}	Output Capacitance	V _{CE} = 30V, V _{GE} = 0V, f = 1MHz	-111	110	146	pF
C _{res}	Reverse Transfer Capacitance	I – IMITZ	-	60	90	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	WW. TOW. COM	-	32	41	ns
t _r	Rise Time	TAMN'IN COM'T		59	77	ns
t _{d(off)}	Turn-Off Delay Time	V _{CC} = 400V, I _C = 50A,	-	160	208	
t _f	Fall Time	$R_G = 6.0\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 25^{\circ}C$	rw -		200	ns
_			, -	22	29	ns ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C	CM-	22 2.7		V.LV
	Turn-On Switching Loss Turn-Off Switching Loss	Inductive Load, T _C = 25°C			29	ns
E _{off}		Inductive Load, T _C = 25°C	-W-	2.7	29 3.5	ns mJ
E _{off}	Turn-Off Switching Loss	Inductive Load, T _C = 25°C	TVI-	2.7 0.74	29 3.5 0.96	ns mJ mJ
E _{off} E _{ts} t _{d(on)}	Turn-Off Switching Loss Total Switching Loss	Inductive Load, T _C = 25°C	TW-	2.7 0.74 3.44	29 3.5 0.96	ns mJ mJ mJ
E _{off} E _{ts} t _{d(on)} t _r	Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time	V _{CC} = 400V, I _C = 50A,	10N-	2.7 0.74 3.44 29	29 3.5 0.96 4.46	ns mJ mJ mJ
E _{off} E _{ts} t _{d(on)} t _r t _{d(off)}	Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time	$V_{CC} = 400V, I_{C} = 50A,$ $R_{G} = 6.0\Omega, V_{GE} = 15V,$	10N-	2.7 0.74 3.44 29 72	29 3.5 0.96 4.46 -	ns mJ mJ mJ ns
E_{off} E_{ts} $t_{\mathrm{d(on)}}$ t_{r} $t_{\mathrm{d(off)}}$	Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time	V _{CC} = 400V, I _C = 50A,	10N-	2.7 0.74 3.44 29 72 166	29 3.5 0.96 4.46 -	ns mJ mJ mJ ns ns
E _{off} E _{ts} t _{d(on)} t _r t _{d(off)}	Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{CC} = 400V, I_{C} = 50A,$ $R_{G} = 6.0\Omega, V_{GE} = 15V,$		2.7 0.74 3.44 29 72 166 19	29 3.5 0.96 4.46 -	ns mJ mJ mJ ns ns ns
Eon	Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss	$V_{CC} = 400V, I_{C} = 50A,$ $R_{G} = 6.0\Omega, V_{GE} = 15V,$		2.7 0.74 3.44 29 72 166 19 3.5	29 3.5 0.96 4.46 -	ns mJ mJ ns ns ns ns mJ mJ

WWW.100Y.CO

WWW.100Y.C

WWW.100Y.Q WWW.100Y WWW.1007

WWW.100

WWW.10

MTW

OM.TW

N.COM.

ox.com

Electrical Characteristics of the IGBT (Continued)

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Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Units
Qg	Total Gate Charge	TW WY 100X	TIME	230	345	nC
Q _{ge}	Gate to Emitter Charge	V _{CE} = 400V, I _C = 50A, V _{GE} = 15V	1.00	31	47	nC
Q _{gc}	Gate to Collector Charge	V _{GE} - 15V	CODIT.	130	195	nC

Electrical Characteristics of the Diode T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Condition	ns	Min.	Тур.	Max	Units
V_{FM}	Diode Forward Voltage	I _F = 30A	$T_{\rm C} = 25^{\rm o}{\rm C}$	57 C	2.1	2.7	V
TIM T	Blode I diward voltage	IF - OOA	$T_{\rm C} = 175^{\rm o}{\rm C}$	100.	1.78	-	1
E _{rec}	Reverse Recovery Energy	Y.CO. TW	$T_{\rm C} = 175^{\rm o}{\rm C}$	109X.	46	- T	uJ
t _{rr} Dioc	Diode Reverse Recovery Time	$I_F = 30A$, $dI_F/dt = 200A/\mu s$	$T_C = 25^{\circ}C$	100Y	41	53	ns
			$T_{\rm C} = 175^{\rm o}{\rm C}$	N.70	144	TV	
Q _{rr}	Diode Reverse Recovery Charge	$00x$. COW_{IM}	$T_{\rm C} = 25^{\rm o}{\rm C}$	M-100	76	106	nC
ort €	blode Neverse Necestery Gharge	100Y.COM.TW	$T_{\rm C} = 175^{\rm o}{\rm C}$	10	486	NJJ	

Figure 1. Typical Output Characteristics

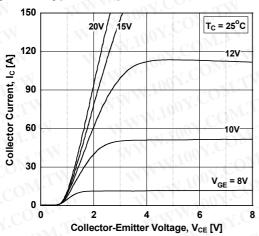


Figure 3. Typical Saturation Voltage Characteristics

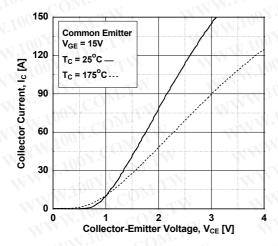


Figure 5. Saturation Voltage vs. Case

Temperature at Variant Current Level

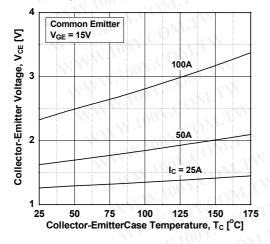


Figure 2. Typical Output Characteristics

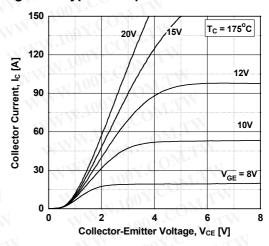


Figure 4. Transfer Characteristics

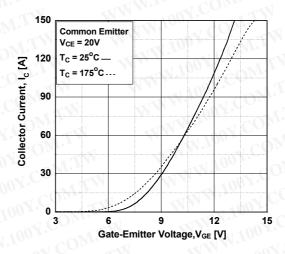


Figure 6. Saturation Voltage vs. V_{GE}

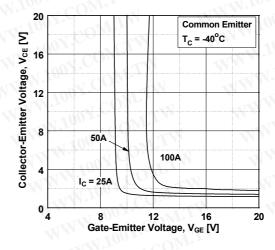


Figure 7. Saturation Voltage vs. V_{GE}

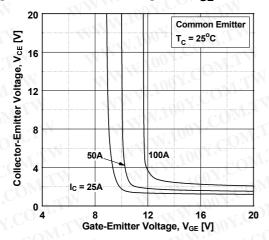


Figure 9. Capacitance Characteristics

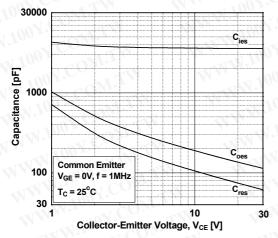


Figure 11. SOA Characteristics

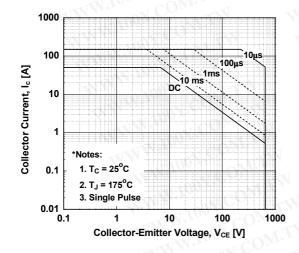


Figure 8. Saturation Voltage vs. V_{GE}

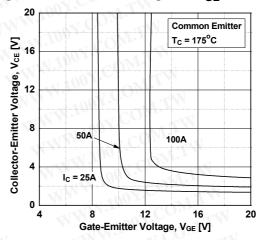


Figure 10. Gate charge Characteristics

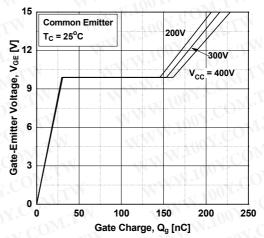


Figure 12. Turn-on Characteristics vs.
Gate Resistance

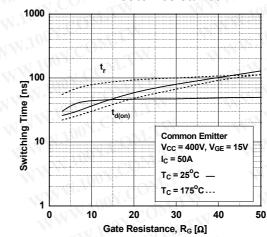


Figure 13. Turn-off Characteristics vs.
Gate Resistance

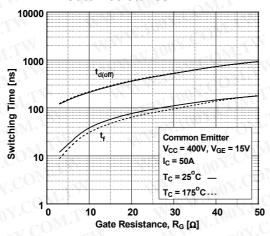


Figure 15. Turn-off Characteristics vs.
Collector Current

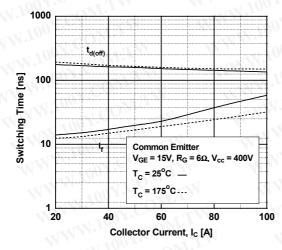


Figure 17. Switching Loss vs. Collector Current

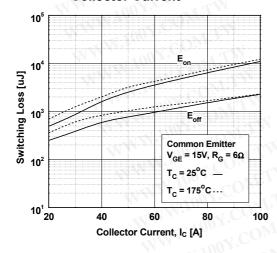


Figure 14. Turn-on Characteristics vs.
Collector Current

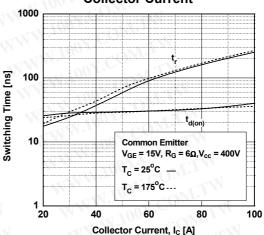


Figure 16. Switching Loss vs.
Gate Resistance

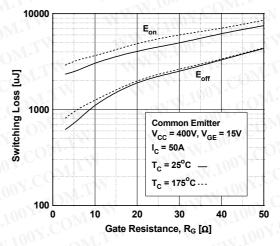


Figure 18. Turn off Switching SOA Characteristics

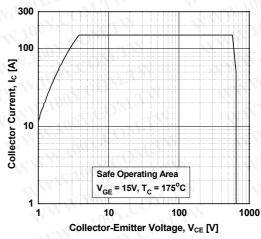


Figure 19. Current Derating

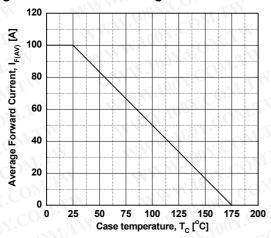


Figure 21. Forward Characteristics

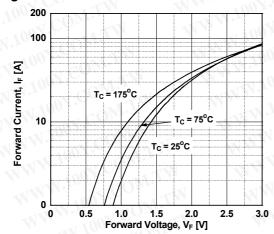


Figure 23. Stored Charge

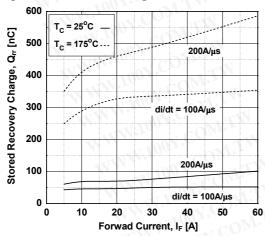


Figure 20. Load Current Vs. Frequence

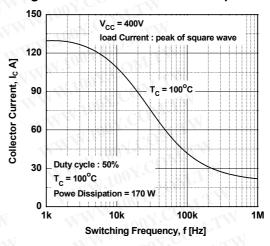


Figure 22. Reverse Recovery Current

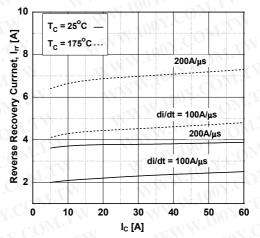


Figure 24. Reverse Recovery Time

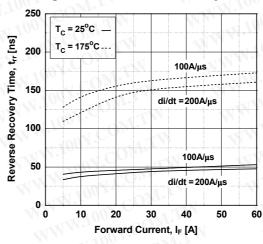


Figure 25. Transient Thermal Impedance of IGBT

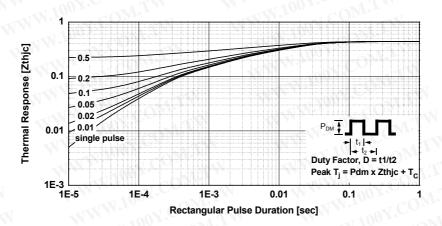
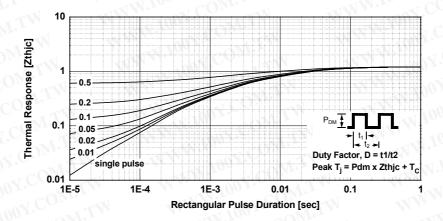
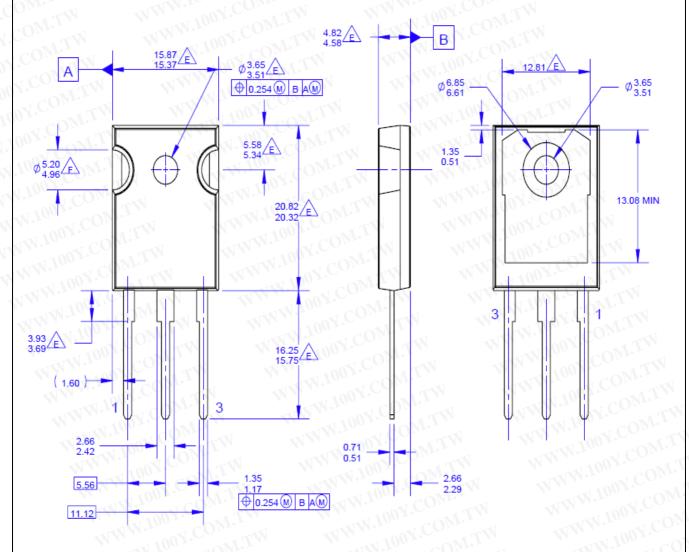


Figure 26.Transient Thermal Impedance of Diode



Mechanical Dimensions

TO - 247AB (FKS PKG CODE 001)



NOTES: UNLESS OTHERWISE SPECIFIED

- A. PACKAGE REFERENCE: JEDEC TO-247, ISSUE E, VARIATION AB, DATED JUNE, 2004.
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5 1994

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G. DRAWING FILENAME: MKT-TO247A03_REV03



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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
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